TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $\pi$ -MOSII<sup>.5</sup>)

# 2SK1489

#### **Chopper Regulator Applications**

- Low drain-source ON resistance  $: R_{DS}(ON) = 0.8 \Omega$  (typ.)
- High forward transfer admittance  $: |Y_{fs}| = 6.0 \text{ S (typ.)}$
- Low leakage current  $: IDSS = 300 \ \mu A \ (max) \ (VDS = 800 \ V)$
- Enhancement-mode :  $V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA})$

#### Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V <sub>DSS</sub>	1000	V
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		V <sub>DGR</sub>	1000	V
Gate-source voltage		V <sub>GSS</sub>	±30	V
Drain current	DC (Note 1)	۱ <sub>D</sub>	12	А
	Pulse (Note 1)	I <sub>DP</sub>	36	A
Drain power dissipation (Tc = 25°C)		PD	200	W
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature range		T <sub>stg</sub>	-55~150	°C

## **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch−c)</sub>	0.625	°C / W
Thermal resistance, channel to ambient	R <sub>th (ch−a)</sub>	35.7	°C / W

¢3.3±0.2 20.5 max 2.50 1.0  $5.45 \pm 0.15$  $5.45 \pm 0.15$ +0.250.6-0.101.GATE 2.DRAIN (HEAT SINK) 3.SOURCE JEDEC \_ JEITA \_\_\_\_ TOSHIBA 2-21F1B

Weight: 9.75 g (typ.)

Note 1: Please use devices on condition that the channel temperature is below 150°C.

This transistor is an electrostatic sensitive device. Please handle with caution. Unit: mm

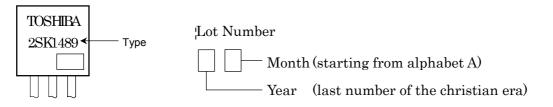
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	urrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V	_	_	±100	nA
Drain cut-off cu	rrent	IDSS	V <sub>DS</sub> = 800 V, V <sub>GS</sub> = 0 V		_	300	μA
Drain-source br	reakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	1000	_	_	V
Gate threshold	voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6 A	_	0.8	1.0	Ω
Forward transfe	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 6 A	4.0	6.0	_	S
Input capacitance	ce	C <sub>iss</sub>		_	2000	_	
Reverse transfe	r capacitance	C <sub>rss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	220	_	pF
Output capacitance		C <sub>oss</sub>			360	_	
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{}_{OV} \prod I_{D} \stackrel{I_{D}=6A}{}_{OVOUT}$	_	100	_	
	Turn-on time	t <sub>on</sub>	$\begin{array}{c c} & & & & \\ & & & & \\ & & & & \\ & & & & $	_	140	_	
	Fall time	t <sub>f</sub>	$V_{\text{DD}} = 400 \text{V}$	_	150	_	ns
	Turn-off time	t <sub>off</sub>	Duty $\leq 1\%$ , t <sub>w</sub> = 10 $\mu$ s	_	500	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	110	_	
Gate-source charge		Q <sub>gs</sub>	V <sub>DD</sub> ≈ 400 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A		50	_	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>			60	_	

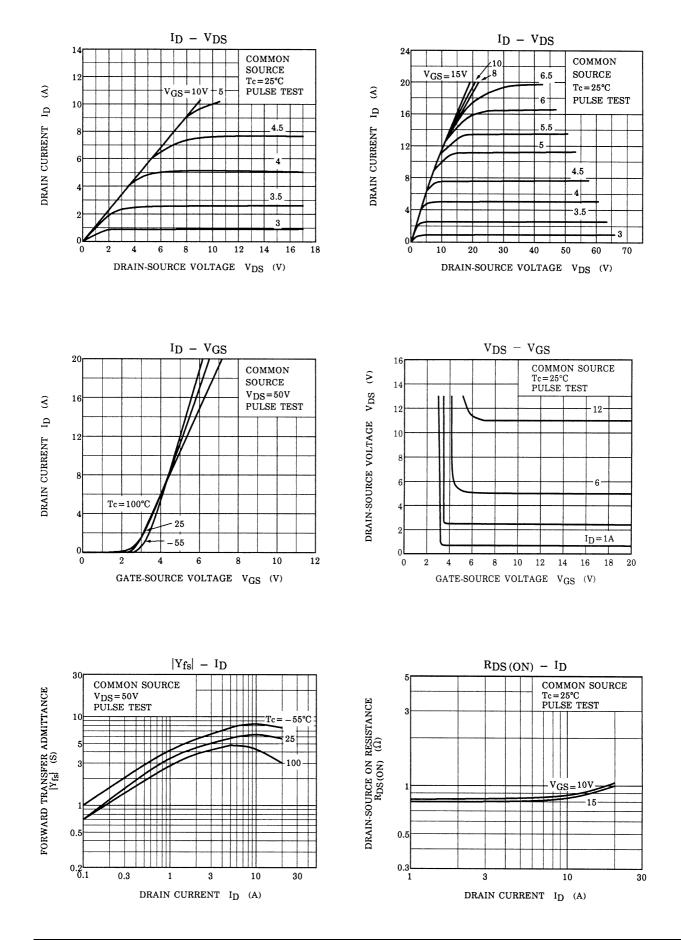
# Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	12	А
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	—	_	_	36	А
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 12 A, V <sub>GS</sub> = 0 V	_		-1.6	V

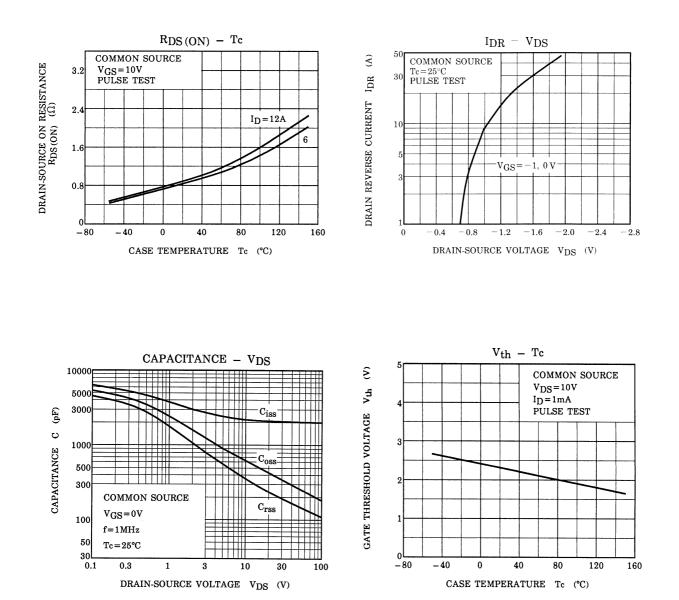
## Marking

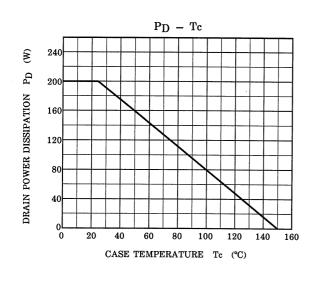


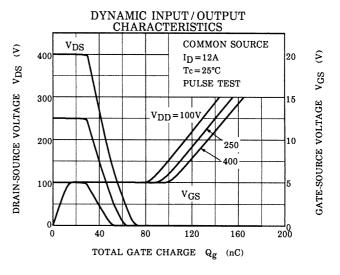
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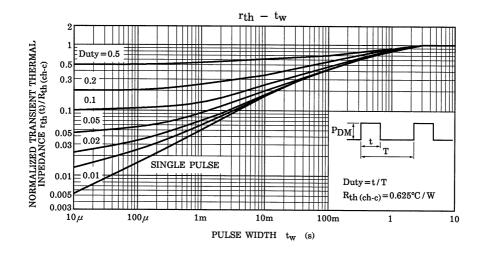


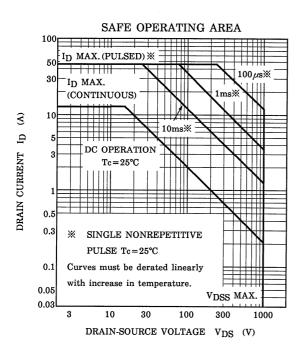
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